

-----  
[Keithley] [Melles Griot Photonics Components]

## Surface Micromachining of Diamond for Fabrication of MEMS Microstructures

Diamond bridges and cantilevers are formed by selective deposition and selective etching.

NASA's Jet Propulsion Laboratory, Pasadena, California

A surface-micromachining process has been devised for use in fabricating microscopic polycrystalline diamond structures (e.g., bridges and cantilevers) as integral parts of microelectromechanical systems (MEMS). The general concept of MEMS encompasses such diverse objects as simple mechanical actuators, simple mechanical sensors, or complex units containing electronic or optoelectronic circuitry integrated with mechanical sensors and/or actuators. Because diamond is highly resistant to corrosion and is transparent, the ability to form diamond structures could contribute to the development of MEMS to withstand corrosive environments. For example, diamond structures could serve as supports for corrosion-resistant electrodes in MEMS designed for biomedical applications. MEMS containing diamond films could also prove useful as automotive sensor and display devices.

An explanation of the distinction between surface and bulk micromachining is prerequisite to a description of the present diamond-surface-micromachining process. In bulk micromachining, three-dimensional features are etched into the bulk of a crystalline or noncrystalline material. In surface micromachining, features are built up, layer by layer, on a substrate of single-crystal silicon or other suitable material. The features in a given layer are defined by dry etching or selective deposition. Then the structure containing the feature is released from the substrate by wet etching (and consequent undercutting) of the substrate material.

The present diamond-surface-micromachining process is best described in terms of experiments in which it was first demonstrated. The starting substrates in the experiments were mirror-smooth, (100)-oriented single-crystal silicon wafers that were, variously, p- or n-doped to a resistivity  $<20 \text{ } \Omega \cdot \text{cm}$ . The wafers were cleaned, then thermally oxidized to a depth of 1 to 1.5 micrometers.

Each substrate was prepared for selective deposition of diamond, following either procedure A or procedure B described below:

Procedure A. To increase the density of nucleation sites for diamond and thereby make it possible to obtain a pinhole-free diamond deposit, the surface of the oxidized substrate was damaged by ultrasonic agitation in methanol containing diamond particles. The ultrasonically damaged SiO<sub>2</sub> substrate surface was photolithographically patterned. By use of a buffered oxide-etch solution, the wafer was partially chemically etched through the openings in the photoresist to remove the damaged oxide surface layer and thereby define the areas where diamond was not to be deposited. The photoresist was then removed by commercial stripping solutions and the substrate cleaned in an oxygen plasma.

Procedure B. The SiO<sub>2</sub> substrate surface was photolithographically

patterned, then the substrate was hard-baked at a temperature of 150 to 200°C. The substrate (with the photoresist still in place) was subjected to ultrasonic agitation in methanol containing diamond particles, so that the SiO<sub>2</sub> surface areas exposed through the holes in the photoresist mask would be damaged and would therefore become sites for deposition of diamond. Then the photoresist was stripped off and the substrate cleaned as in procedure A.

Following procedure A or B, the substrate was cleaned, then placed in a chemical-vapor-deposition (CVD) chamber. Polycrystalline diamond was grown on the patterned and damaged SiO<sub>2</sub> areas by CVD from a flowing mixture of methane and hydrogen, typically at a total pressure of 45 torr (6 kPa) and a substrate temperature of 950 °C.

The diamond-patterned substrate was cleaned in solvents. In a photolithographic process, a new photoresist pattern was formed to define the portions of the substrate to be etched away from the diamond. Then by use of a buffered oxide-etch solution, the SiO<sub>2</sub> layer on the substrate was removed from under selected diamond-patterned areas, leaving diamond structures supported over airgaps (bridges and cantilevers).

[Image]

Optical photographs show Diamond Beams and Diamond Cantilever Beams that were fabricated using selective diamond deposition and subsequent micromachining process.

This work was done by Rajeshuni Ramesham of Caltech for NASA's Jet Propulsion Laboratory. For further information, access the Technical Support Package (TSP) free on-line at [www.nasatech.com](http://www.nasatech.com) under the category. Download detailed Technical Support Package for this Brief